

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/790,880	AKIYAMA ET A	L.
Examiner	Art Unit	
Denise Tran	2188	

SEARCHED					
	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
text search (USPAT, USPGPUB,USOCR,EPOAB,JPOAB,D ERWENT, IBM-TDB)	3/30/2008	DT		
711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	3/30/2008	DT		
711/103,105, 167; 365/189.01 (text search only search history)	3/30/2008	DT		
inventor name search	3/30/2008	DT		